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Key indicators

Single-crystal X-ray study
 $T = 293$ K
Mean $\sigma(\text{In-Pd}) = 0.002$ Å
 R factor = 0.040
 wR factor = 0.112
Data-to-parameter ratio = 15.0

For details of how these key indicators were
automatically derived from the article, see
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Intermetallic CePdIn

Cerium palladium indide, CePdIn, crystallizes in the hexagonal space group $P\bar{6}2m$ and belongs to the ZrNiAl structure type.

Received 1 April 2004
Accepted 13 April 2004
Online 24 April 2004

Comment

During systematic studies of the ternary cerium–palladium–indium system, the intermetallic compound CePdIn was obtained. In the Ce–Pd–In system, four ternary compounds have been investigated previously by single-crystal X-ray diffraction: CePdIn₂ (Ijiri *et al.*, 1996), Ce₄Pd₁₀In₂₁ (Zaremba *et al.*, 2003), CePd₂In₄ (Tursina *et al.*, 2003), and CePd₃In₂ (Nesterenko *et al.*, 2004).

CePdIn crystallizes in the ZrNiAl-type structure (Krypyakevich *et al.*, 1967), which is an ordered variant of the binary compound Fe₂P (Rundqvist & Jellinek, 1959). Up to now, only lattice parameters of CePdIn have been determined (Ferro *et al.*, 1974; Brück *et al.*, 1993). Each Ce atom is surrounded by five Pd and six In atoms, which form a distorted pentagonal prism with one additional atom [Pd₅In₆]. Atom Pd1 is coordinated by six Ce atoms forming a trigonal prism [at a distance of 3.0710 (8) Å] and three additional In atoms capping the square faces at 2.9484 (19) Å. Atom Pd2 is at the center of a similar polyhedron formed by six In atoms at 2.777 (2) Å and three Ce atoms at 3.183 (3) Å. The In atom is surrounded by a distorted tetragonal prism with four additional atoms [Ce₆Pd₄In₂] (Fig. 1).

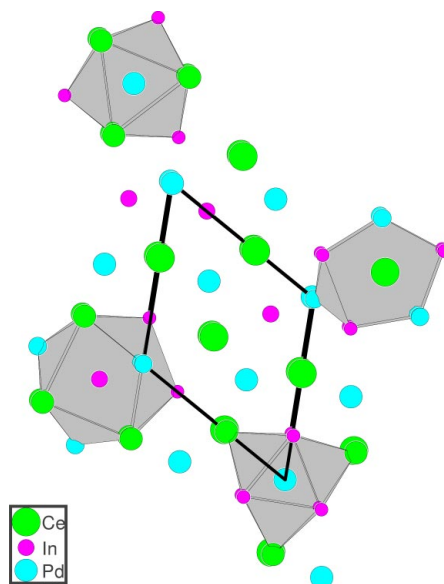


Figure 1

A view of the CePdIn structure along the c axis. Part of the structure is shown in the polyhedral representation.

Experimental

The title compound was prepared by direct arc melting of high purity components (Ce 98.0, Pd 99.9, In 99.9 wt% pure) under an argon atmosphere. The sample with nominal composition $\text{Ce}_{33}\text{Pd}_{34}\text{In}_{33}$ was annealed in an evacuated double quartz ampoule at 770 K over a period of 600 h and quenched in cold water. Weight loss was less than 1% of the total mass of 1.0 g. A single crystal was selected from the surface of the resulting alloy.

Crystal data

CePdIn	Mo $K\alpha$ radiation
$M_r = 361.34$	Cell parameters from 25 reflections
Hexagonal, $P\bar{6}2m$	$\theta = 7.3\text{--}18.9^\circ$
$a = 7.7036$ (15) Å	$\mu = 30.63 \text{ mm}^{-1}$
$c = 4.0190$ (14) Å	$T = 293$ (2) K
$V = 206.56$ (9) Å ³	Prism, metallic dark grey
$Z = 3$	$0.09 \times 0.03 \times 0.03 \text{ mm}$
$D_x = 8.715 \text{ Mg m}^{-3}$	

Data collection

Enraf–Nonius CAD-4 diffractometer	$R_{\text{int}} = 0.077$
ω scans	$\theta_{\text{max}} = 27.1^\circ$
Absorption correction: ψ scan (North <i>et al.</i> , 1968)	$h = 0 \rightarrow 9$
$T_{\text{min}} = 0.285$, $T_{\text{max}} = 0.393$	$k = -9 \rightarrow 8$
551 measured reflections	$l = 0 \rightarrow 5$
195 independent reflections	1 standard reflection
171 reflections with $I > 2\sigma(I)$	frequency: 120 min
	intensity decay: 1%

Refinement

Refinement on F^2	$(\Delta/\sigma)_{\text{max}} < 0.001$
$R[F^2 > 2\sigma(F^2)] = 0.040$	$\Delta\rho_{\text{max}} = 1.59 \text{ e \AA}^{-3}$
$wR(F^2) = 0.112$	$\Delta\rho_{\text{min}} = -1.90 \text{ e \AA}^{-3}$
$S = 0.80$	Absolute structure: Flack (1983), 118 Friedel pairs
195 reflections	Flack parameter = 0.38 (14)
13 parameters	
$w = 1/[\sigma^2(F_o^2) + (0.1P)^2]$	
where $P = (F_o^2 + 2F_c^2)/3$	

Table 1

Selected interatomic distances (Å).

In–Pd ²	2.777 (2)	In–Ce ⁱⁱⁱ	3.4267 (18)
In–Pd ⁱ	2.9484 (19)	Ce–Pd ^{iiv}	3.0710 (8)
In–Ce	3.290 (3)	Ce–Pd ^{iv}	3.183 (3)
In–In ⁱⁱ	3.319 (5)		

Symmetry codes: (i) $x, y - 1, z$; (ii) $-x, -x + y, z$; (iii) $y, x - 1, z$; (iv) y, x, z ; (v) $1 + x, y, z$.

Refinement of the structure, taking into account inversion twinning, did not result in a significant improvement. The highest peak and the deepest hole in the difference map are located 1.92 Å from In and 0.76 Å from Ce, respectively.

Data collection: *CAD-4 EXPRESS* (Enraf–Nonius, 1994); cell refinement: *CAD-4 EXPRESS*; data reduction: *XCAD4* (Harms & Wocadlo, 1995); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *DIAMOND* (Brandenburg, 1998); software used to prepare material for publication: *WinGX* (Farrugia, 1999).

This work was supported by the INTAS project No. 00-234.

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